


<b>Search Notes</b>  	<b>Application/Control No.</b>  10816175	<b>Applicant(s)/Patent Under Reexamination</b>  KENEN ET AL.
	<b>Examiner</b>  San Juan, Martin Jeriko P	<b>Art Unit</b>  2132

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (See attached)	5/03/07	MJSJ
Inventor Search -- (Reviewed related applications.)	5/14/07	MJSJ
Updated EAST Search (See attached.)	2/1/2008	MJSJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner